Search Notes



plication/Control No.	Applicant(s)/Patent under Reexamination
200 740	EAD OUENOUNA

Ap

10/602,749	EAR, CHENGLI	М
Examiner	Art Unit	
/BINH K. TIEU/	2614	

SEARCHED				
Class	Subclass	Date	Examiner	
Updated	Search	3/3/2008	ВКТ	

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
WEST DATABASES SEARCH	3/3/2008	вкт		